

Notice of References Cited	Application/Control No. 10/763,715	Applicant(s)/Patent Under Reexamination AMARA ET AL.	
	Examiner Hae M. Hyeon	Art Unit 2839	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,059,616	05-2000	Bluemmel et al.	439/867
	B	US-6,217,394	04-2001	Sugie, Naoto	439/752.5
	C	US-2002/0045388 A1	04-2002	Miwa, Takeya	439/877
	D	US-6,375,501	04-2002	Kojima, Eiji	439/595
	E	US-6,478,620	11-2002	Bonavita et al.	439/595
	F	US-6,669,507	12-2003	Yamanashi et al.	439/595
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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